



High-end Power Semiconductor Manufacturer

# KP3200A 2000V-2800V

## Phase Control Thyristor

- High power cycling capability
- Low on-state and switching losses
- Designed for traction and industrial applications



Mean on-state current	I <sub>TAV</sub>	3200 A			
Repetitive peak off-state voltage	V <sub>DRM</sub>	2000 – 2800 V			
Repetitive peak reverse voltage	V <sub>RRM</sub>				
Turn-off time	t <sub>q</sub>	400 μs			
V <sub>DRM</sub> , V <sub>RRM</sub> , V	2000	2200	2400	2600	2800
Voltage code	20	22	24	26	28
T <sub>j</sub> , °C			– 60 – 125		

### MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions	
<b>ON-STATE</b>					
I <sub>TAV</sub>	Mean on-state current	A	3200	T <sub>c</sub> = 85 °C, Double side cooled 180° half-sine wave; 50 Hz	
I <sub>TRMS</sub>	RMS on-state current	A	5024	T <sub>c</sub> = 85 °C, Double side cooled 180° half-sine wave; 50 Hz	
I <sub>TSM</sub>	Surge on-state current	kA	60.0 69.0	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 50 Hz (t <sub>p</sub> =10 ms); single pulse; V <sub>D</sub> =V <sub>R</sub> =0 V; Gate pulse: I <sub>G</sub> =2 A; t <sub>GP</sub> =50 μs; di <sub>G</sub> /dt≥1 A/μs
			63.0 72.0	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 60 Hz (t <sub>p</sub> =8.3 ms); single pulse; V <sub>D</sub> =V <sub>R</sub> =0 V; Gate pulse: I <sub>G</sub> =2 A; t <sub>GP</sub> =50 μs; di <sub>G</sub> /dt≥1 A/μs
I <sup>2</sup> t	Safety factor	A <sup>2</sup> ·10 <sup>3</sup>	18000 23805	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 50 Hz (t <sub>p</sub> =10 ms); single pulse; V <sub>D</sub> =V <sub>R</sub> =0 V; Gate pulse: I <sub>G</sub> =2 A; t <sub>GP</sub> =50 μs; di <sub>G</sub> /dt≥1 A/μs
			16470 21510	T <sub>j</sub> =T <sub>j</sub> max T <sub>j</sub> =25 °C	180° half-sine wave; 60 Hz (t <sub>p</sub> =8.3 ms); single pulse; V <sub>D</sub> =V <sub>R</sub> =0 V; Gate pulse: I <sub>G</sub> =2 A; t <sub>GP</sub> =50 μs; di <sub>G</sub> /dt≥1 A/μs

### BLOCKING

V <sub>DRM</sub> , V <sub>RRM</sub>	Repetitive peak off-state and Repetitive peak reverse voltages	V	2000–2800	T <sub>j min</sub> < T <sub>j</sub> <T <sub>j max</sub> ; 180° half-sine wave; 50 Hz; Gate open
V <sub>DSM</sub> , V <sub>RSM</sub>	Non-repetitive peak off-state and Non-repetitive peak reverse voltages	V	2100–2900	T <sub>j min</sub> < T <sub>j</sub> <T <sub>j max</sub> ; 180° half-sine wave; 50 Hz;single pulse; Gate open
V <sub>D</sub> , V <sub>R</sub>	Direct off-state and Direct reverse voltages	V	0.75·V <sub>DRM</sub> 0.75·V <sub>RRM</sub>	T <sub>j</sub> =T <sub>j</sub> max; Gate open

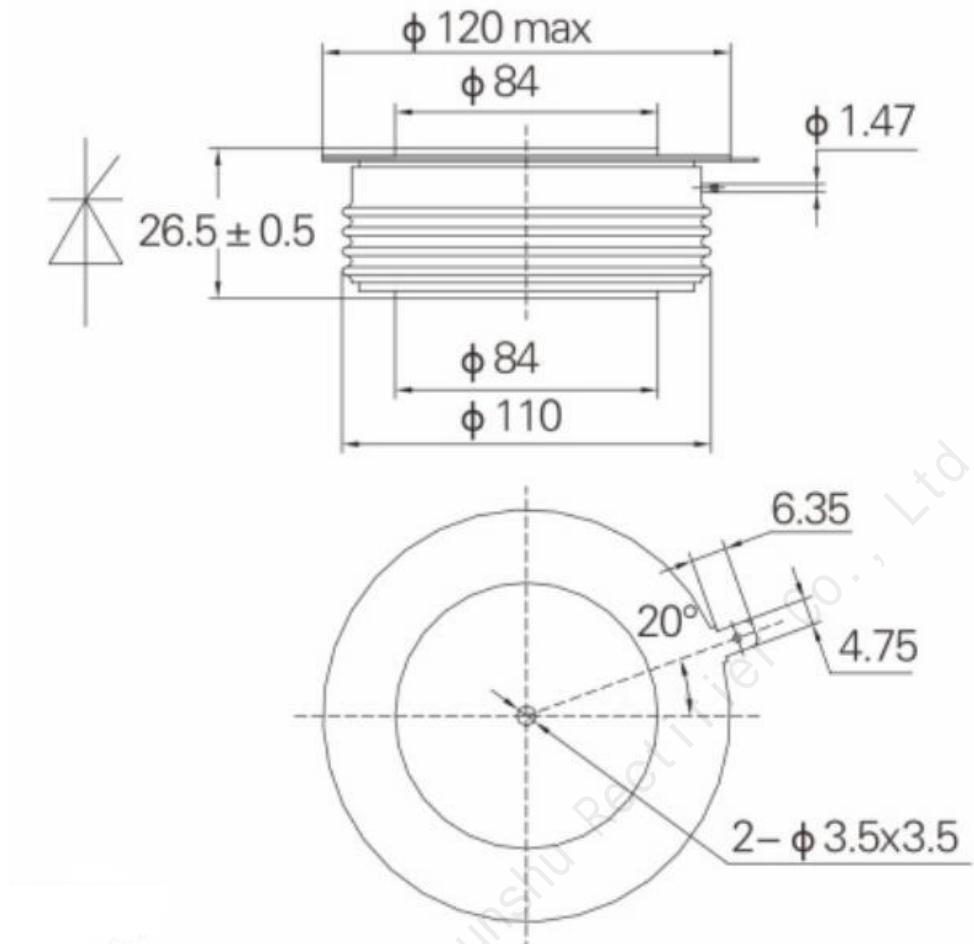
TRIGGERING				
$I_{FGM}$	Peak forward gate current	A	10	$T_j = T_{j \max}$
$V_{RGM}$	Peak reverse gate voltage	V	5	
$P_G$	Gate power dissipation	W	5	$T_j = T_{j \max}$ for DC gate current
SWITCHING				
$(di_T/dt)_{crit}$	Critical rate of rise of on-state current non-repetitive ( $f=1$ Hz)	A/ $\mu$ s	630	$T_j = T_{j \max}; V_D = 0.67 \cdot V_{DRM}; I_{TM} = 2 I_{TAV};$ Gate pulse: $I_G = 2$ A; $t_{GP} = 50 \mu$ s; $di_G/dt \geq 1$ A/ $\mu$ s
THERMAL				
$T_{stg}$	Storage temperature	°C	-60 – 125	
$T_j$	Operating junction temperature	°C	-60 – 125	
MECHANICAL				
F	Mounting force	kN	60.0 – 70.0	
a	Acceleration	m/s <sup>2</sup>	50 100	Device unclamped Device clamped

## CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions		
<b>ON-STATE</b>						
$V_{TM}$	Peak on-state voltage, max	V	1.65	$T_j = 25$ °C; $I_{TM} = 6300$ A		
$V_{T(TO)}$	On-state threshold voltage, max	V	1.00	$T_j = T_{j \max};$		
$r_T$	On-state slope resistance, max	$m\Omega$	0.125	$0.5 \pi I_{TAV} < I_T < 1.5 \pi I_{TAV}$		
$I_L$	Latching current, max	mA	1500	$T_j = 25$ °C; $V_D = 12$ V; Gate pulse: $I_G = 2$ A; $t_{GP} = 50 \mu$ s; $di_G/dt \geq 1$ A/ $\mu$ s		
$I_H$	Holding current, max	mA	300	$T_j = 25$ °C; $V_D = 12$ V; Gate open		
<b>BLOCKING</b>						
$I_{DRM}, I_{RRM}$	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	200	$T_j = T_{j \max};$ $V_D = V_{DRM}; V_R = V_{RRM}$		
$(dv_D/dt)_{crit}$	Critical rate of rise of off-state voltage <sup>1)</sup> , min	V/ $\mu$ s	1000	$T_j = T_{j \max};$ $V_D = 0.67 \cdot V_{DRM};$ Gate open		
<b>TRIGGERING</b>						
$V_{GT}$	Gate trigger direct voltage, max	V	3.00 2.00	$T_j = 25$ °C $T_j = T_{j \max}$	$V_D = 12$ V; $I_D = 3$ A; Direct gate current	
$I_{GT}$	Gate trigger direct current, max	mA	300 200	$T_j = 25$ °C $T_j = T_{j \max}$		
$V_{GD}$	Gate non-trigger direct voltage, min	V	0.35	$T_j = T_{j \max};$ $V_D = 0.67 \cdot V_{DRM};$		
$I_{GD}$	Gate non-trigger direct current, min	mA	15.00	Direct gate current		
<b>SWITCHING</b>						
$t_{gd}$	Delay time	$\mu$ s	4.00	$T_j = 25$ °C; $V_D = 0.4 \cdot V_{DRM}; I_{TM} = 2000$ A; Gate pulse: $I_G = 2$ A; $t_{GP} = 50 \mu$ s; $di_G/dt \geq 1$ A/ $\mu$ s		
$t_q$	Turn-off time <sup>2)</sup> , max	$\mu$ s	400	$dv_D/dt = 50$ V/ $\mu$ s; $T_j = T_{j \max}; I_{TM} = 2000$ A; $di_R/dt = -10$ A/ $\mu$ s; $V_R = 100$ V; $V_D = 0.67 \cdot V_{DRM};$		

<b>THERMAL</b>					
$R_{thjc}$	Thermal resistance, junction to case, max	$^{\circ}\text{C}/\text{W}$	0.0065	Direct current	Double side cooled
$R_{thjc-A}$			0.0143		Anode side cooled
$R_{thjc-K}$			0.0117		Cathode side cooled
$R_{thck}$	Thermal resistance, case to heatsink, max	$^{\circ}\text{C}/\text{W}$	0.0015	Direct current	
<b>MECHANICAL</b>					
W	Weight, typ	g	1900		
$D_s$	Surface creepage distance	mm (inch)	36.50 (1.437)		
$D_a$	Air strike distance	mm (inch)	16.5 (0.650)		

## OVERALL DIMENSIONS



KT90

All dimensions in millimeters